

<b>Notice of References Cited</b>	Application/Control No. 10/711,002	Applicant(s)/Patent Under Reexamination SHEI ET AL.	
	Examiner Christopher M. Raabe	Art Unit 2879	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0080341	05-2003	Sakano et al.	257/79
*	B	US-2002/0096687	07-2002	Kuo et al.	257/99
*	C	US-6,121,638	09-2000	Rennie et al.	257/103
*	D	US-4,774,205	09-1988	Choi et al.	438/23
*	E	US-2001/0008484	07-2001	Kato et al.	362/267
*	F	US-5,998,925	12-1999	Shimizu et al.	313/503
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.